

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination CHRISTIE ET AL.	
		Examiner Raymond Alejandro	Art Unit 1745	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,756,140	06-2004	McAlister, Roy E.	429/20
	C	US-			
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	J	US-			
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	M	US-			

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	N	JP 04-115470	04-1992	Japan	Maekawa et al	H01M 08/18
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NON-PATENT DOCUMENTS

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